

Dual N-Channel Enhancement Mode Power MOSFET

Description

The HM8810Ó uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications .It is ESD protested.

General Features

● V_{DS} = 20V,I_D =7A

 $R_{DS(ON)}$ < 27m Ω @ V_{GS} =2.5V

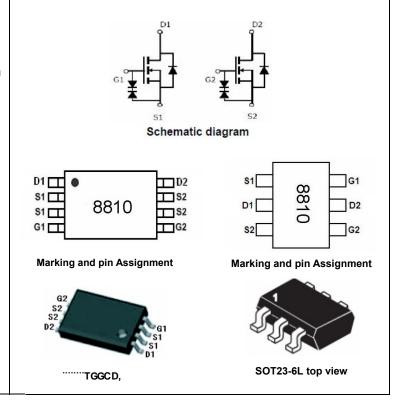
 $R_{DS(ON)}$ < 21m Ω @ V_{GS} =4.5V

ESD Rating: 2000V HBM

- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- PWM application
- Load switch



Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
8810	HM8810Ó	TSSOP8/SOT-23-6L	Ø330mm	12mm	3000 units

Absolute Maximum Ratings (TA=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	20	V
Gate-Source Voltage	V _{GS}	±12	V
Drain Current-Continuous	I _D	7	Α
Drain Current-Pulsed (Note 1)	I _{DM}	30	Α
Maximum Power Dissipation	P _D	1.5	W
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}$

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2) R _{BJA} 83.3 °C/W	Themal Resistance, sunction to Ambient (Note 2)	$R_{\theta JA}$	83.3	°C/W
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Electrical Characteristics (TA=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	20		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V,V _{GS} =0V	-	-	1	μA

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Gate-Body Leakage Current	I _{GSS}	$V_{GS}=\pm10V, V_{DS}=0V$	-	-	±10	μΑ
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	0.55	0.7	0.95	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =6.5A	-	15	21	mΩ
Drain-Source On-State Resistance		V _{GS} =2.5V, I _D =5.5A	-	20	27	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =7A	-	20	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	V _{DS} =10V,V _{GS} =0V,	-	1150	-	PF
Output Capacitance	Coss	F=1.0MHz	-	185	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0IVII 12	-	145	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	6		nS
Turn-on Rise Time	t _r	V_{DD} =10V,R _L =1.35 Ω	-	13		nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =5 V , R_{GEN} =3 Ω	-	52		nS
Turn-Off Fall Time	t _f		-	16		nS
Total Gate Charge	Qg	\/ -10\/ -74	-	15		nC
Gate-Source Charge	Q_{gs}	$V_{DS}=10V,I_{D}=7A,$ $V_{GS}=4.5V$	-	0.8	-	nC
Gate-Drain Charge	Q_{gd}	VGS-4.5V	-	3.2	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =1A	-	-	1.2	V
Diode Forward Current (Note 2)	I _S		-	-	7	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

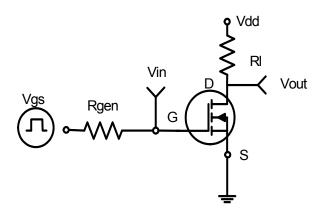


Figure 1:Switching Test Circuit

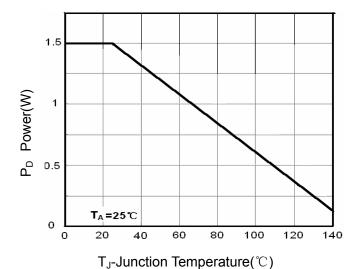


Figure 3 Power Dissipation

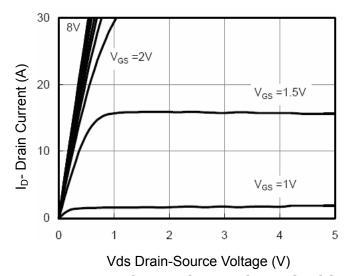


Figure 5 Output CHARACTERISTICS

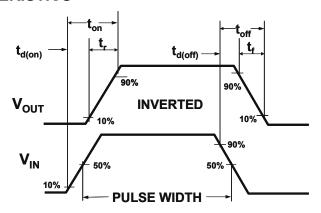


Figure 2:Switching Waveforms

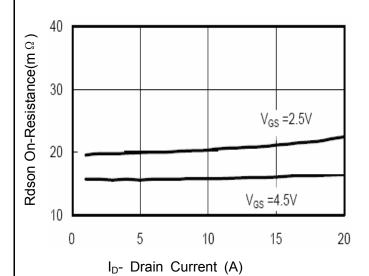


Figure 6 Drain-Source On-Resistance

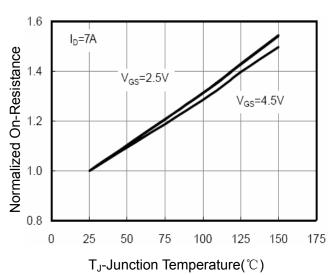
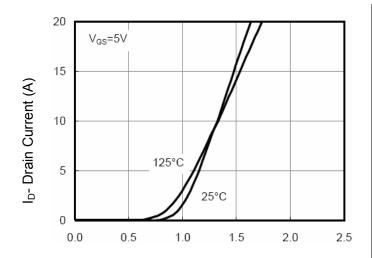


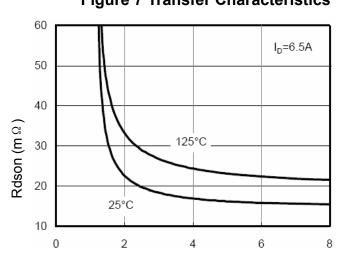
Figure 8 Drain-Source On-Resistance

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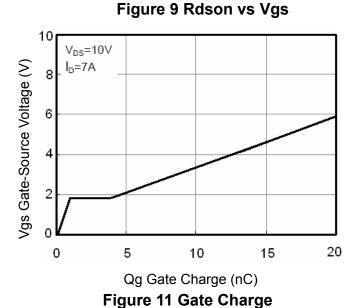
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Vgs Gate-Source Voltage (V)
Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)



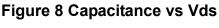
2000 1600 C_{iss}

C_{oss}

0

5
10
15
20

Vds Drain-Source Voltage (V)



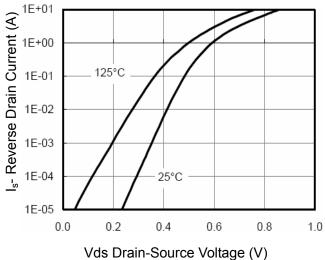


Figure 10 Capacitance vs Vds

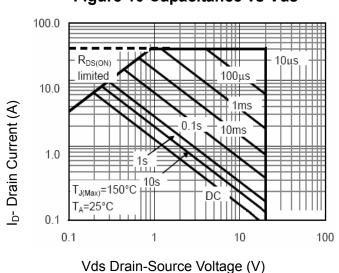


Figure 13 Safe Operation Area

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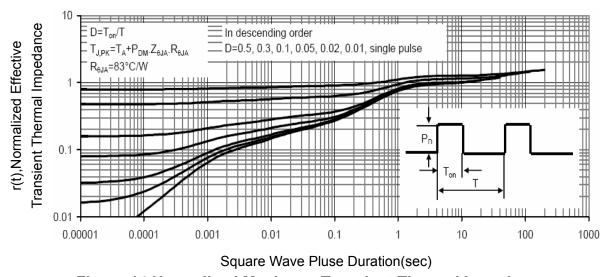
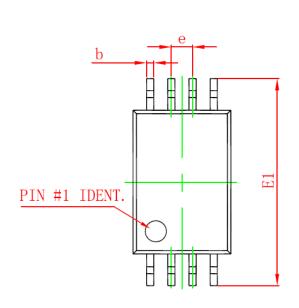
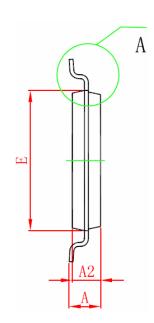
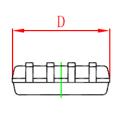


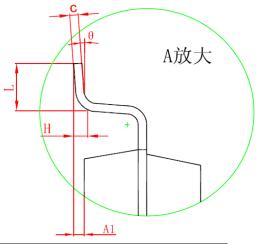
Figure 14 Normalized Maximum Transient Thermal Impedance

TSSOP-8 PACKAGE INFORMATION







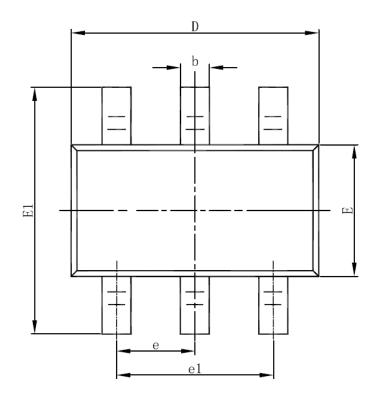


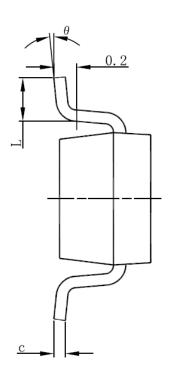
Symbol	Dimensions In Millimeters			
Symbol	Min	Max		
D	2.900	3.100		
E	4.300	4.500		
b	0.190	0.300		
С	0.090	0.200		
E1	6.250	6.550		
Α		1.100		
A2	0.800	1.000		
A 1	0.020	0.150		
е	0.65(BSC)			
L	0.500	0.700		
Н	0.25(TYP)			
Θ	1°	7°		

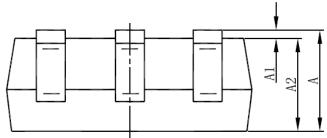
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SOT23-6L PACKAGE INFORMATION







Ck a l	Dimensions Ir	n Millimeters	Dimensions	s In Inches
Symbol	Min	Max	Min	Max
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

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